

# HAL<sup>®</sup> 1870

Programmable Linear Hall-Effect Sensor  
with PWM Output

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– HAL

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## Programmable Linear Hall-Effect Sensor with PWM Output

### 1. Introduction

The HAL 1870 is a universal programmable Hall-effect sensor with pulse-width modulation (PWM) output. The signal value is proportional to the magnetic flux density applied to the sensor surface. The sensor can be used for magnetic-field measurements such as current measurements and detection of mechanical movement, such as small-angle or distance measurements. This robust sensor can be used in harsh electrical and mechanical environments.

Major characteristics like magnetic-field range, sensitivity, offset (signal voltage at zero magnetic field) and the temperature coefficients are programmable in a non-volatile memory. Several output signal clamping levels can be programmed. Diagnostic features are implemented to indicate various fault conditions like undervoltage, under-/overflow or overtemperature.

The HAL 1870 is programmable by modulating the voltage with a serial telegram on the sensor's output pin or supply pin. No additional programming pin is needed. Several sensors on the same supply line can be programmed individually (communication through OUT pins). This programmability allows a 2-point calibration by adjusting the output signal directly to the input signal, such as mechanical angle, distance or current.

Individual adjustment of each sensor during the customer's manufacturing process is possible. With this calibration procedure, the tolerance of the sensor, the magnet and the mechanical positioning can be compensated in the final assembly.

The spinning-current offset compensation leads to stable magnetic characteristics over supply voltage and temperature. Furthermore, the first-order and second-order temperature coefficients of the sensor sensitivity can be used to compensate the temperature drift of all common magnetic materials. This enables operation over the full temperature range with high accuracy.

The calculation of the individual sensor characteristics and the programming of the EEPROM memory can easily be done with a PC and the application kit from TDK-Micronas.

The sensor is designed for industrial and automotive applications, is AEC-Q100 qualified, and operates in the junction temperature range from  $-40\text{ }^{\circ}\text{C}$  up to  $170\text{ }^{\circ}\text{C}$ . The HAL 1870 is available in the very small leaded packages TO92UA-1 and TO92UA-2.

## 1.1. Major Applications

Thanks to the sensors' robust and cost-effective design, the HAL 1870 is the optimal system solution for applications such as:

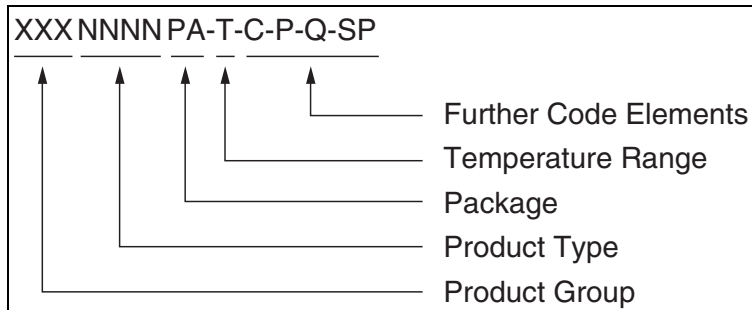
- Small-angle or linear position measurements
- Gear position detection in transmission application
- Current sensing for battery management
- Rotary selector

## 1.2. Features

- Up to 2 kHz PWM output proportional to the magnetic field
  - Selectable PWM polarity
  - Selectable start-up behavior
- Digital signal processing
- Continuous measurement ranges from  $\pm 20$  mT to  $\pm 160$  mT
- Selectable clamping levels with selectable diagnosis
- Comprehensive diagnostic feature set
- Lock function and built-in redundancy for EEPROM memory
- Programmable temperature characteristics for matching all common magnetic materials
- Programming via output pin or supply voltage modulation
- On-chip temperature compensation
- Active offset compensation
- Operates from  $-40$  °C up to  $170$  °C junction temperature
- Operates from  $4.5$  V up to  $5.5$  V supply voltage in specification
- Operates with static and dynamic magnetic fields up to  $5$  kHz
- Selectable sampling frequency ( $8$  kSps or  $16$  kSps)
- Overvoltage and reverse-voltage protection at VSUP pin
- Magnetic characteristics extremely robust against mechanical stress
- Short-circuit protected open-drain output
- EMC and ESD optimized design
- AEC-Q100 qualified

## 2. Ordering Information

A Micronas device is available in a variety of delivery forms. They are distinguished by a specific ordering code:



**Fig. 2–1:** Ordering code principle

For a detailed information, please refer to the brochure: “Sensors and Controllers: Ordering Codes, Packaging, Handling”.

### 2.1. Device-Specific Ordering Codes

HAL 1870 is available in the following package and temperature variants.

**Table 2–1:** Available packages

Package Code (PA)	Package Type
UA	TO92UA

**Table 2–2:** Available temperature ranges

Temperature Code (T)	Temperature Range
A	$T_J = -40\text{ °C to }170\text{ °C}$

The relationship between ambient temperature ( $T_A$ ) and junction temperature ( $T_J$ ) is explained in Section 5.1. on page 34.

For available variants for Configuration (C), Packaging (P), Quantity (Q), and Special Procedure (SP) please contact TDK-Micronas.

**Table 2–3:** Available ordering codes and corresponding package marking

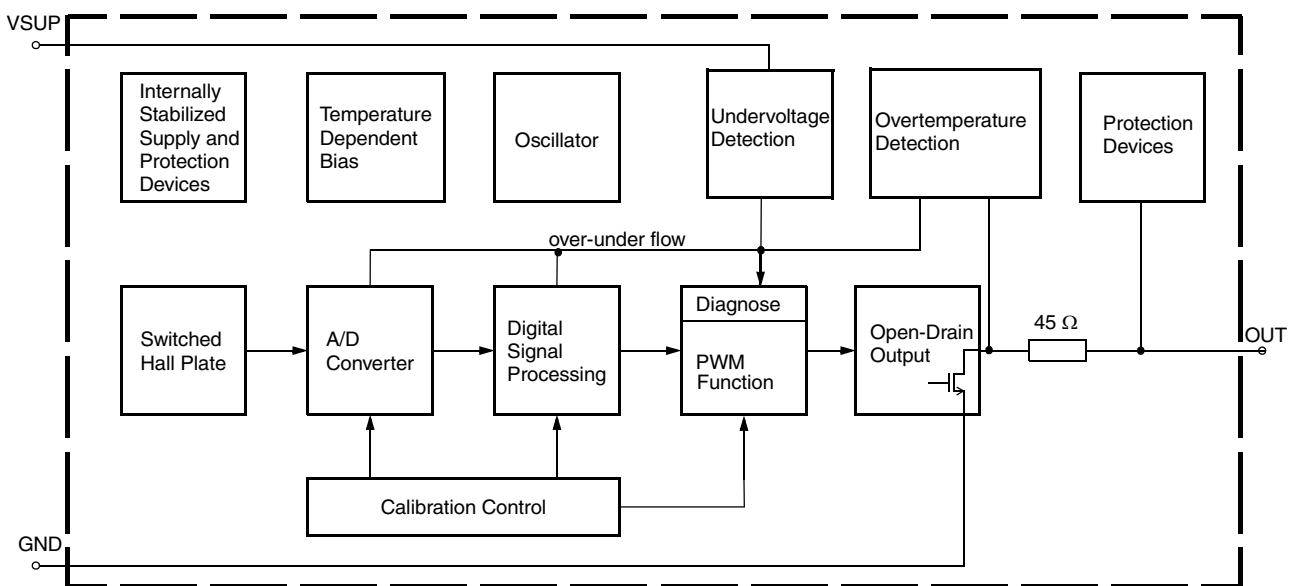
Available Ordering Codes	Package Marking
HAL 1870UA-A-[C-P-Q-SP]	1870A

## 3. Functional Description

### 3.1. General Function

The HAL 1870 is a monolithic integrated circuit (IC) which provides a PWM output signal proportional to the magnetic flux through the Hall plate and proportional to the supply voltage (ratiometric behavior).

The Hall IC is sensitive to magnetic north and south polarity. This Hall voltage is converted to a digital value, processed in the Digital Signal Processing unit (DSP) according to the settings of the EEPROM registers, converted into a PWM signal and output by an open-drain NMOS transistor. Selectable clamping levels for the output signal as well as diagnostic features are available. The function and the parameter for the DSP are explained in Section 3.2. on page 8. Internal temperature compensation circuitry and spinning-current offset compensation enable operation over the full temperature range with minimal degradation in accuracy and offset. The circuitry also rejects offset shifts due to mechanical stress from the package. In addition, the sensor IC is equipped with devices for overvoltage and reverse polarity protection at supply pin.

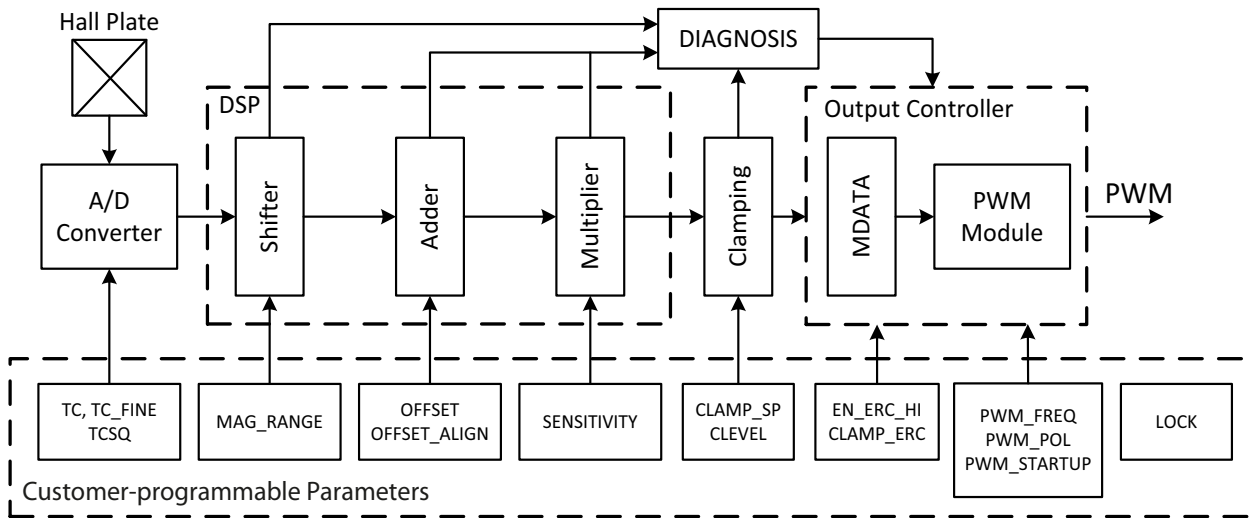


**Fig. 3–1:** HAL 1870 block diagram

The IC can be programmed via supply or output pin voltage modulation. After detecting a command, the sensor reads or writes the memory and answers with a digital signal on the output pin. As long as the LOCK register is not set, the output characteristic can be adjusted by programming the EEPROM registers. The LOCK register disables the programming of the EEPROM memory. This register cannot be reset.

Furthermore, HAL 1870 features an internal error detection. The following error modes can be detected: over-/underflow in adder or multiplier, over-/underflow in A/D converter (ADC) and overtemperature.

### 3.2. Digital Signal Processing and EEPROM



**Fig. 3–2:** Details of Programming Parameter and Digital Signal Processing

**Table 3–1:** Cross reference table for EEPROM register and sensor parameter

EEPROM Register	Parameter	Data Bits	Function
Customer Setup 1	DSDOUBLE	1	Sampling frequency selection
	CLEVEL	2	Output clamping values selection
	EN_ERC_HI	1	Set signal path's overflow and underflow behavior
	TC_FINE	1	Fine adjustment of linear temperature coefficient
	PWM_FREQ	2	PWM frequency selection
	PWM_POL	1	PWM polarity selection
	PWM_STARTUP	1	PWM start-up behavior
Customer Setup 2	LOCK	1	Customer lock
	CLAMP_SP	1	Activates unbalanced clamping levels
	CLAMP_ERC	1	Activates Error Flag on PWM output
	OFFSET_ALIGN	1	Magnetic offset alignment bit (MSB or LSB aligned)
	TCSQ	5	Quadratic temperature coefficient
Output Scaling	TC	5	Linear temperature coefficient
	MAG_RANGE	3	Available magnetic ranges
	SENSITIVITY	8	Magnetic sensitivity
Micronas ID1	OFFSET	8	Magnetic offset
	MIC_ID_1	16	Micronas production information (read only)
Micronas ID2	MIC_ID_2	16	Micronas production information (read only)



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**Note** For more information on the registers and the memory map of the HAL 1870, please refer to the application note “**HAL 1870/1880/1890 User Manual**”.

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The DSP is a key function of this sensor and performs the signal conditioning. The parameters for the DSP are stored in the EEPROM registers. Details are shown in Fig. 3–2 on page 8.

The measurement data can be readout from the digital output register MDATA.

### 3.2.1. Digital Output Register

#### MDATA register

This 16-bit register delivers the actual digital value of the applied magnetic field after the signal processing. This register can only be read out, and it is the basis for the calibration procedure of the sensor in the customer application. Only 12 bits of the register contain valid data. The MDATA range is 0 to 4096, limited by clamping settings.

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**Note** The MDATA range (or MDATA bandwidth) depends on the PWM output frequency  $f_{\text{PWM}}$ :

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$f_{\text{PWM}}$	#bit	MDATA Range
0.25 kHz	12	0:4096
0.5 kHz	12	0:4096
1 kHz	11	0:2048
2 kHz	10	0:1024

---

**Note** The accuracy depends on the sampling frequency  $f_s$ :

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$f_s$	#bit
8 kHz	10
16 kHz	10

The area in the EEPROM accessible to the customer consists of registers with a size of 16 bits each.

For SENSITIVITY >0 the MDATA value will increase for negative magnetic fields (i.e. when a north pole is applied perpendicular to the branded side of the package).

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**Note** During application design, it shall be taken into consideration that the MDATA value should not saturate in the full operational range of the specific application.

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### 3.2.2. Output Scaling Register

The Output Scaling register contains the bits for magnetic sensitivity (SENSITIVITY) and magnetic offset (OFFSET).

#### SENSITIVITY

The SENSITIVITY bits define the parameter for the multiplier in the DSP and is programmable between  $[-2...2]$  in steps of 0.0156. SENSITIVITY = 1 (at Offset = 0) corresponds to full-scale (FS) of the output signal if the A/D converter value has reached the full-scale value. The SENSITIVITY register has a resolution of 8 bits.

## OFFSET

The OFFSET bits define the parameter for the adder in the DSP.

The customer can decide if the offset is MSB or LSB aligned. The MSB or LSB alignment is enabled by an additional offset alignment bit (OFFSET\_ALIGN). In case this bit is set to 1, the offset is programmable from  $-25\%DC$  up to  $25\%DC$ .

If the OFFSET\_ALIGN bit is set to zero, then the offset covers only 1/8 of the full-scale ( $-6.25\%DC$  up to  $6.25\%DC$ ) but with a finer step size. The customer can adjust the offset symmetrically around 50% of  $V_{SUP}$ . The OFFSET register can be set with 8-bit resolution.

### 3.2.3. Micronas ID Number Registers

Micronas ID Number registers contain 16 bits each. TDK-Micronas uses the registers to store production information like wafer position, wafer number and production lot number. These two registers can be read by the customer.

### 3.2.4. Customer Setup 1 Registers

The Customer Setup 1 register contains the bits to select the sampling frequency, to enable/disable the High Error Band for error indication, to define the output signal clamping levels and to adjust the PWM signal.

## PWM\_FREQ

The 2-bit PWM\_FREQ allows to select the PWM frequency between four different values: 250 Hz, 500 Hz, 1 kHz, and 2 kHz.

## PWM\_STARTUP

The bit PWM\_STARTUP determines the output start-up behavior of HAL 1870 during  $t_{startup}$ . The selection of PWM polarity (PWM\_POL) has also an influence.

When PWM\_STARTUP = 0, the output is  $V_{OUT\_H}$  with PWM\_POL = 0 or 30% duty cycle with PWM\_POL = 1.

When PWM\_STARTUP = 1, the output is  $V_{OUT\_L}$  with PWM\_POL = 0 or 70% duty cycle with PWM\_POL = 1.

## PWM\_POL

The bit PWM\_POL determines the polarity of the PWM signal. When PWM\_POL = 0, the PWM signal starts with a falling edge. When PWM\_POL = 1, it starts with a rising edge.

## DSDOUBLE

The bit DSDOUBLE allows to double the sampling frequency. The permitted values are 8 kSps and 16 kSps, corresponding to a bandwidth of 2.5 kHz and 5 kHz.

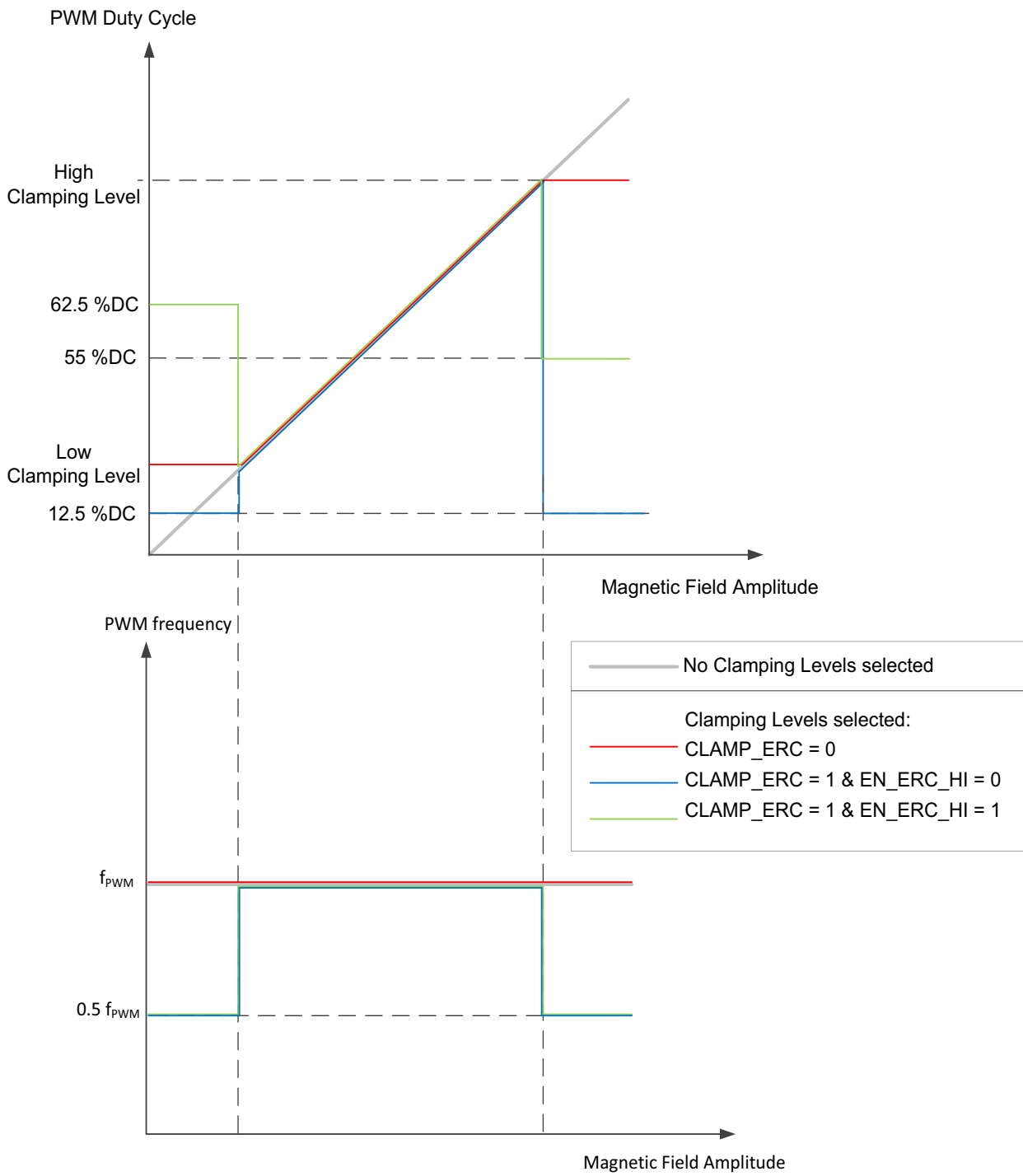
## CLEVEL

The 2-bit CLEVEL together with CLAMP\_SP select the clamping levels, i.e. the maximum and minimum output voltage levels of the PWM output. The following choices are available {CLAMP\_SP:CLEVEL}:

**Table 3–2:** Clamping level definition

CLAMP_SP	CLEVEL	Clamping Level (%DC)	
		low	high
0	00	0 (clamping disabled)	100 (clamping disabled)
0	01	5	95
0	10	10	90
0	11	15	85
1	00	5	90
1	01	10	95
1	10	20	90
1	11	10	80

Clamping is normally not considered as an error. However, the user is able to activate the clamping error code by setting the CLAMP\_ERC bit of the Customer Setup 1 register. In that case the output will be forced to an error state as soon as the output signal reaches the programmed clamping levels. The resulting clamping behavior therefore depends on the selection of the clamping levels, the setting of the CLAMP\_ERC bit, and the setting of the EN\_ERC\_HI bit (Error Code Selection). All possible clamping variations are shown in Fig. 3–3.



**Fig. 3–3:** HAL 1870 clamping behavior

### 3.2.5. Customer Setup 2 Register

Customer Setup 2 register contains the bits for magnetic range (MAG\_RANGE), linear and quadratic temperature coefficients (TC and TCSQ), magnetic offset alignment (OFFSET\_ALIGN), unbalanced clamping levels (CLAMP\_SP) and the customer lock bit.

#### MAG\_RANGE

The MAG\_RANGE bits are used to set the magnetic measurement range. The following eight measurement ranges are available:

**Table 3–3:** MAG\_RANGE bit definition

Magnetic-Field Range	Bit Setting	Comment
–20 mT...20 mT	0	
–40 mT...40 mT	1	
–60 mT...60 mT	2	
–80 mT...80 mT	3	
–100 mT...100 mT	4	
–120 mT...120 mT	5	
–140 mT...140 mT	6	
–160 mT...160 mT	7	

#### TC and TCSQ

The temperature dependence of the magnetic sensitivity can be adapted to different magnetic materials in order to compensate for the change of the magnetic sensitivity with temperature. The adaption is done by programming the TC (linear temperature coefficient) and the TCSQ registers (quadratic temperature coefficient). Thereby, the slope and the curvature of the temperature dependence of the magnetic sensitivity can be matched to the magnet and the sensor assembly. As a result, the output signal characteristic can be fixed over the full temperature range. The sensor can compensate for linear temperature coefficients ranging from about –3100 ppm/K up to 2550 ppm/K and quadratic coefficients from about –7 ppm/K<sup>2</sup> to 15 ppm/K<sup>2</sup> (typical range). Min. and max. values for the quadratic temperature coefficient depend on the linear temperature coefficient. Please refer to Section 5.4. on page 36 for the recommended settings for different linear temperature coefficients.

#### Magnetic Offset Alignment Bit (OFFSET\_ALIGN)

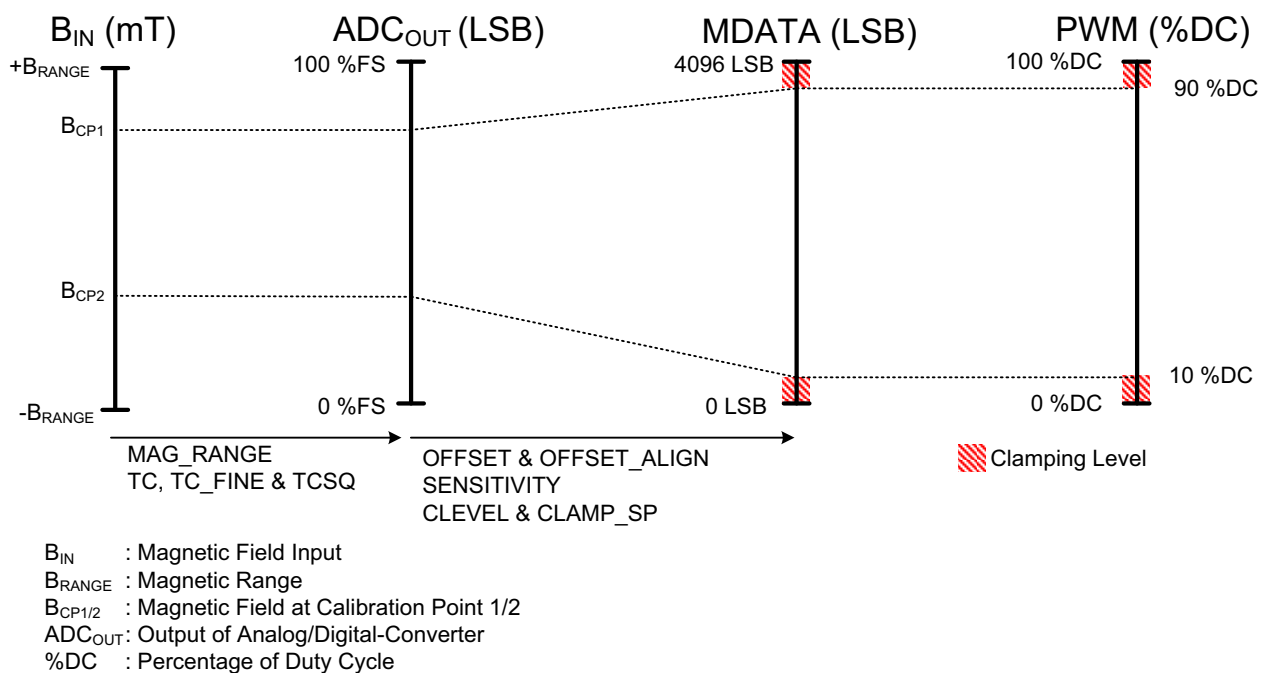
Please refer to Section 3.2.2. on page 10 (OFFSET).

## LOCK

By setting this 1-bit register, all registers will be locked, and the EEPROM content can not be changed anymore. The LOCK bit is active after the first power-off and power-on sequence after setting the LOCK bit.

**Warning** This register cannot be reset!

### 3.2.6. Signal Path



**Fig. 3–4:** Signal path of HAL 1870 (CLAMP\_ERC=0, FPWM=0.5 kHz, MDATA=12 bits)

Fig. 3–4 shows the signal path and signal processing of HAL 1870. The measurement output value MDATA is calculated with the output value of the ADC by the following equation.

$$MDATA \approx SENSITIVITY \times (ADC_{OUT} + OFFSET)$$

The register values OFFSET and SENSITIVITY are two's complement encoded 8-bit values (see Section 3.2.5. on page 14).

### 3.3. On-Board Diagnostic Features

The HAL 1870 features following diagnostic functions:

– **Thermal supervision of the output stage (overcurrent, short circuit, etc.)**

The sensor switches the output to tristate if overtemperature is detected by the thermal supervision.

– **Undervoltage detection with internal reset**

The occurrence of an undervoltage is indicated immediately by switching the output to error state (either low for PWM\_POL=1 or high for PWM\_POL=0). The output will start up after the end of an undervoltage detection event depending on the PWM\_STARTUP and PWM\_POL setting like described in Fig. 3–6.

– **Magnetic signal amplitude out of range (overflow or underflow in ADC)**

– **Over-/underflow in adder or multiplier**

These faults are visible at the output as long as present and will force the output to error state (half of the selected PWM frequency and specific duty cycle) depending on the source of the faults, and the customer parameter settings, such as the sign of the sensitivity and the Error Code Selection bit (see Table 3–4).

**Table 3–4:** Error code source and settings combinations

Settings		Source					
Sign of SENSITIVITY	EN_ERC_HI	A/D Converter		Adder		Multiplier	
		Underflow	Overflow	Underflow	Overflow	Underflow	Overflow
+	1	12.5%DC	85%DC	12.5%DC	85%DC	12.5%DC	85%DC
–		85%DC	12.5%DC	85%DC	12.5%DC		
±	0	12.5%DC		12.5%DC		12.5%DC	

**Note:** In case of error code, the PWM frequency is half of the selected PWM frequency



### 3.4. The PWM Module

HAL 1870 transmits the magnetic-field information by sending a PWM signal.

A pulse-width modulated (PWM) signal consists of successive square-wave pulses. The information is coded in the ratio between high time “ $t_{high}$ ” and signal period “ $t_{period}$ ”.

$$duty\ cycle = \frac{t_{high}}{t_{period}}$$

After reset, the output is recessive high. The transmission starts after the first valid output value has been calculated.

In case of a reset or if overtemperature is detected, the output transistor is switched off. The output state is then high impedance (HiZ). The transistor is enabled again if the overtemperature condition disappears or after the startup time  $t_{startup}$  has elapsed when a reset occurred.

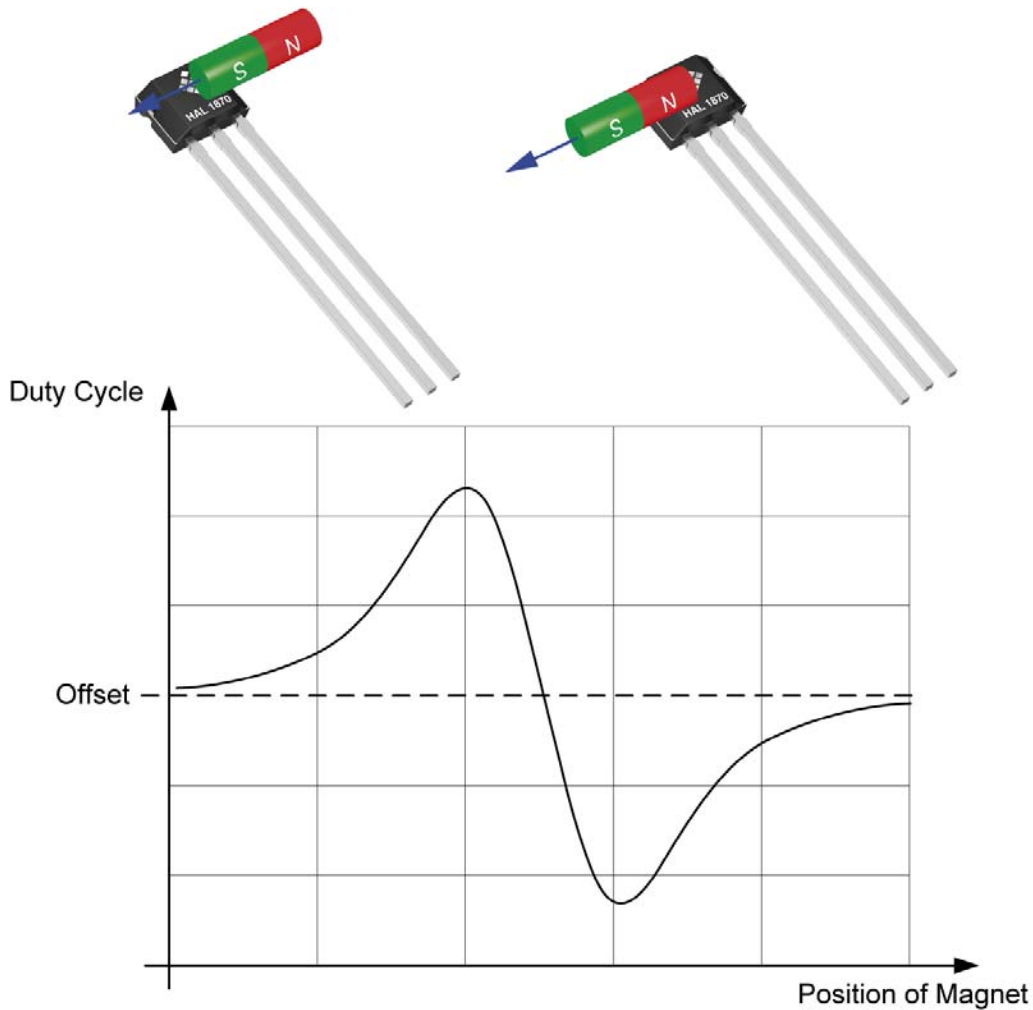
#### 3.4.1. Output Polarity and Startup Behavior

The start-up behavior (PWM\_STARTUP) and the polarity of the PWM (PWM\_POL) signal are selectable by the customer. The different combinations are shown in Fig. 3–6.

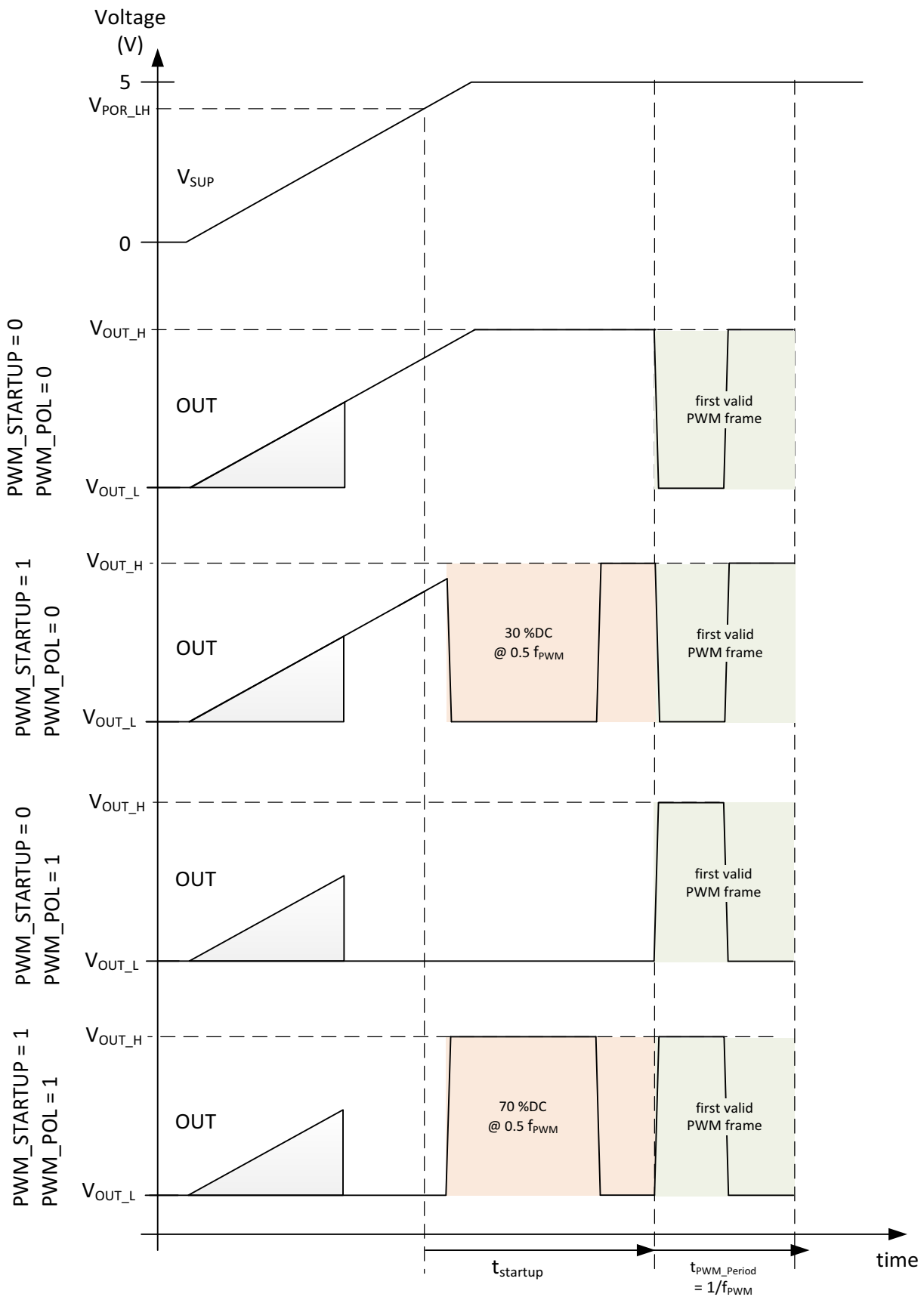
### 3.4.2. Output/Magnetic-Field Polarity

Applying a south-pole magnetic field perpendicular to the branded side of the package will increase the duty cycle (for SENSITIVITY <0 and PWM\_POL=0) from the quiescent (offset) value. A north-pole magnetic field will decrease the duty-cycle value.

The output logic will be inverted for a SENSITIVITY setting >0 or PWM\_POL=1.



**Fig. 3–5:** Duty cycle depending on magnet polarity and position



**Fig. 3–6: PWM interface startup timing**

Section 4.8. on page 28 describes the PWM interface characteristics.

## 3.5. Sensor Calibration

### 3.5.1. General Procedure for Development or Evaluation Purposes

For calibration of the sensor in the customer application, the development tool kit from TDK-Micronas is recommended. It contains the hardware for the generation of the serial telegram during programming and the corresponding software to program the various register values of register values.

For the individual calibration of each sensor in the final customer application, a two-point adjustment is recommended. Please refer to “**HAL 1870/1880/1890 User Manual**” for further details on calibration procedure.

### 3.5.2. Locking the Sensor

For qualification and production purpose the device has to be locked in order to guarantee its functionality.

The last programming step activates the memory lock function by setting the LOCK bit. Please note that the memory lock function becomes effective after power-down and power-up of the Hall IC. The sensors EEPROM is then locked and its content can not be changed nor read anymore.

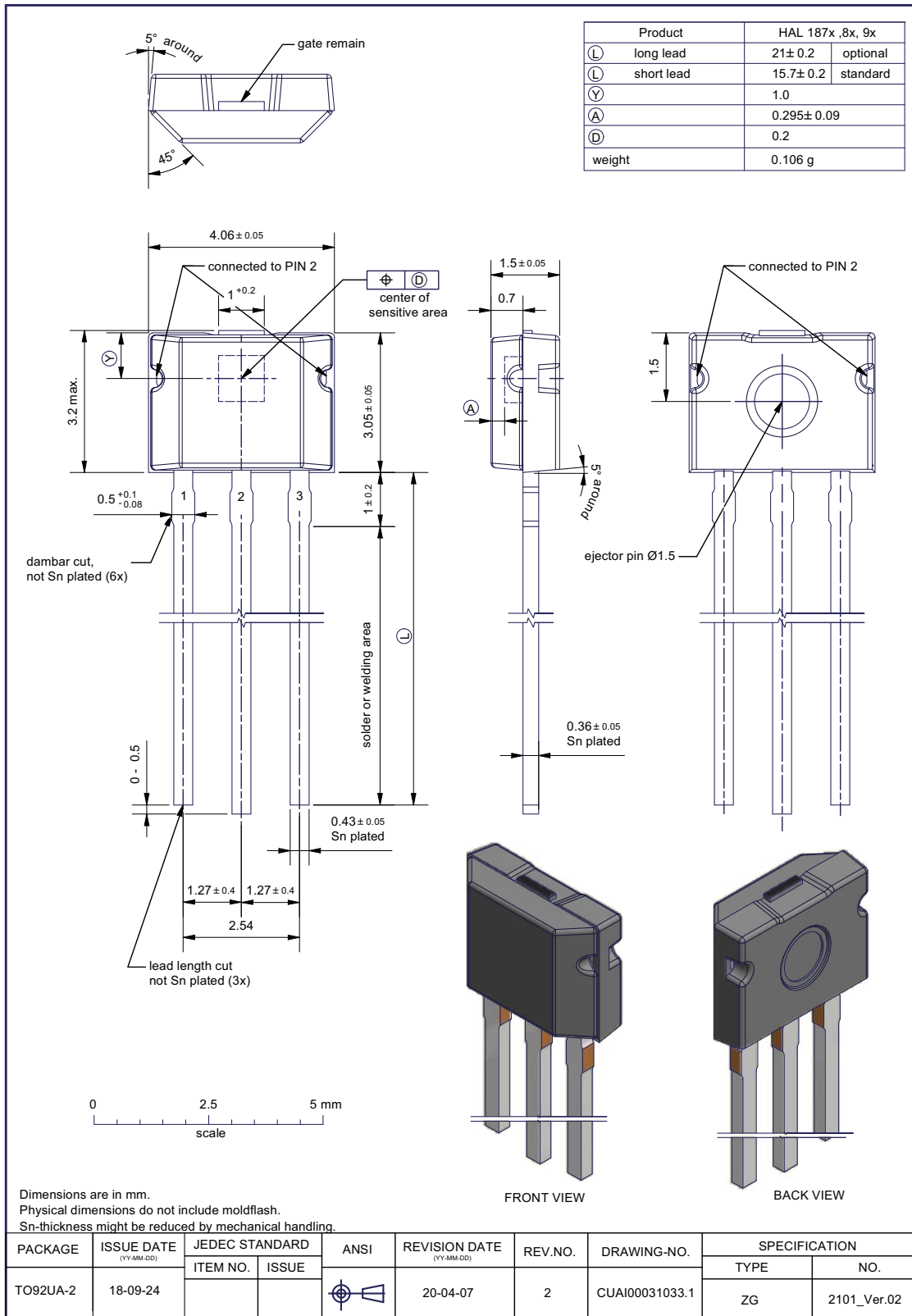
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**Warning** This register cannot be reset!

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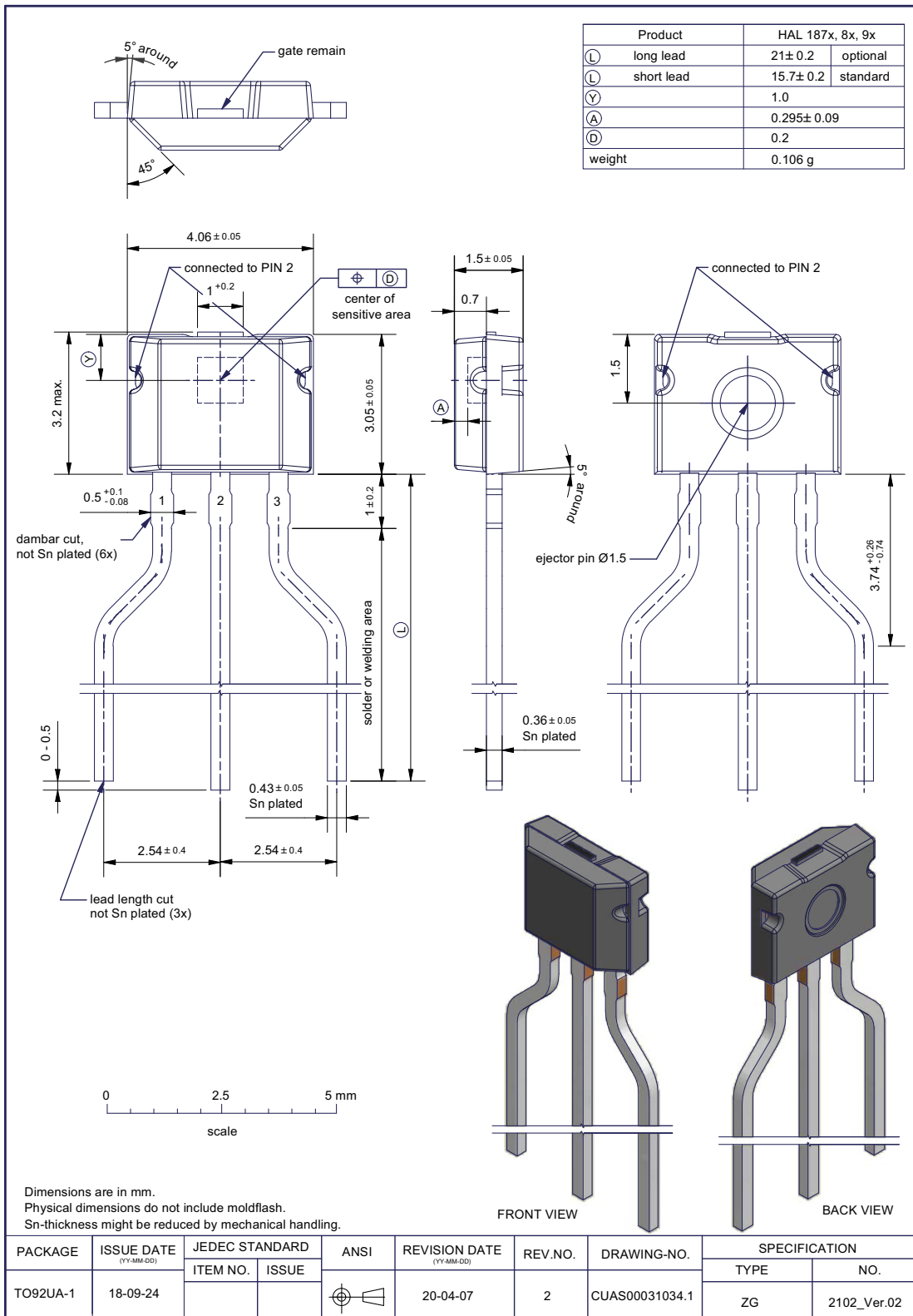
# 4. Specifications

## 4.1. Outline Dimensions

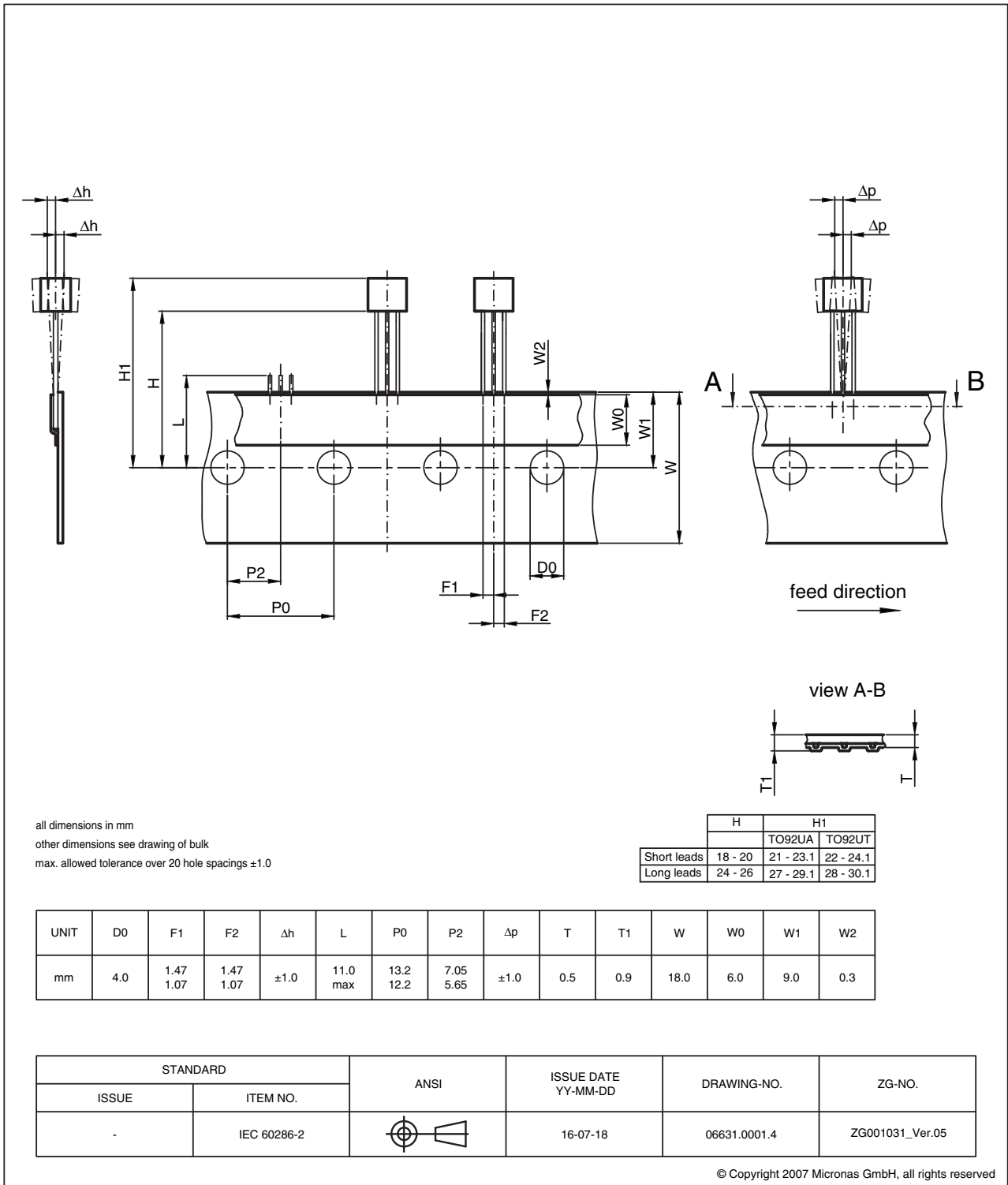


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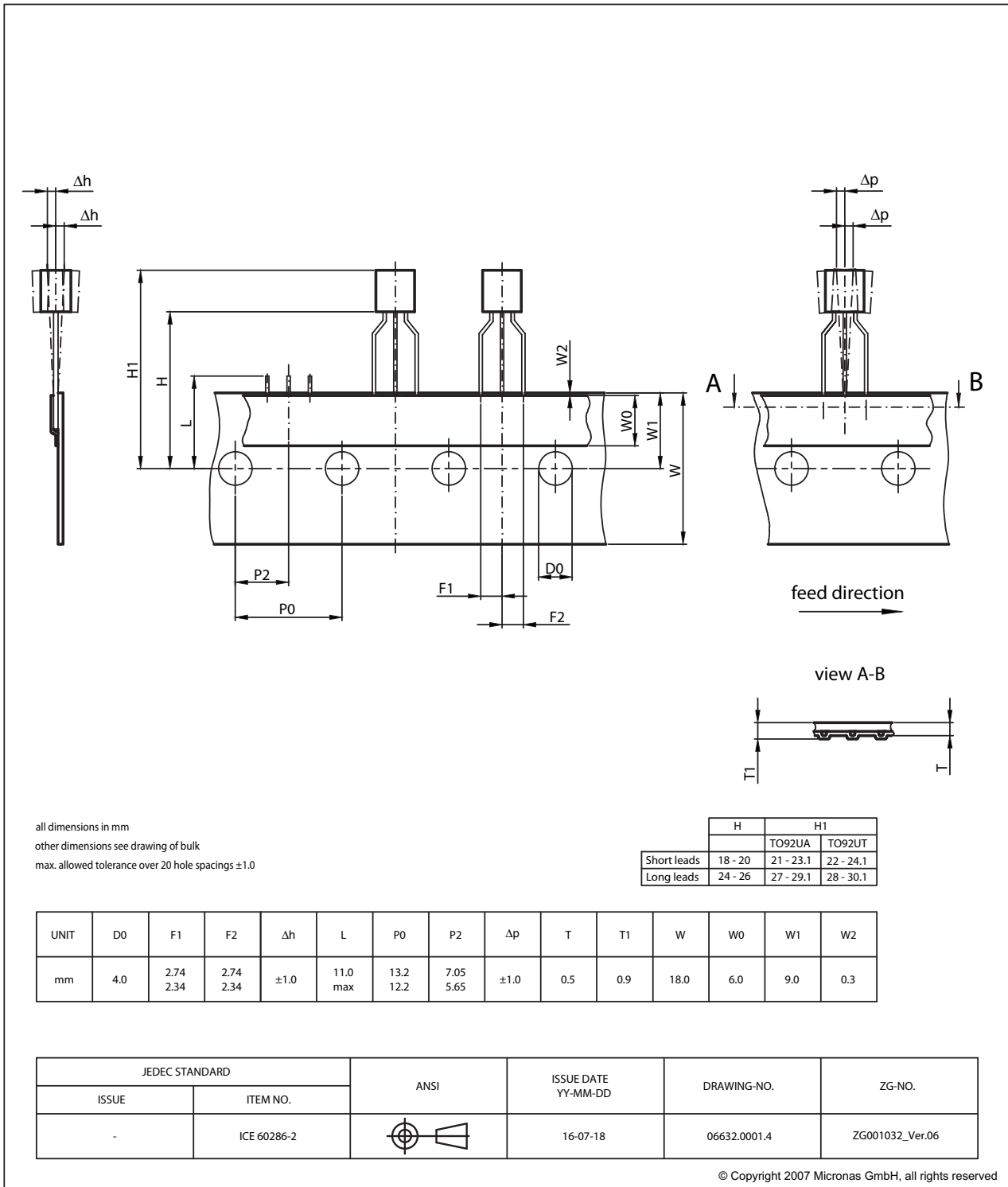
**Fig. 4-1:**  
**TO92UA-2 Plastic Transistor Standard UA package, 3 leads, non-spread**



**Fig. 4-2:**  
**TO92UA-1 Plastic Transistor Standard UA package, 3 leads, spread**



**Fig. 4-3:**  
**TO92UA:** Dimensions ammpack inline, not spread, standard lead length



**Fig. 4-4:**  
**TO92UA:** Dimensions ammpack inline, spread, standard lead length



## 4.2. Soldering, Welding, and Assembly

Information related to solderability, welding, assembly, and second-level packaging is included in the document “Guidelines for the Assembly of Micronas Packages”.

It is available on the TDK-Micronas website (<https://www.micronas.com/en/service-center/downloads>) or on the service portal (<https://service.micronas.com>).

## 4.3. Pin Connections and Short Descriptions

Pin No.	Pin Name	Short Description
1	VSUP	Supply Voltage Pin
2	GND	Ground
3	OUT	PWM Output Pin

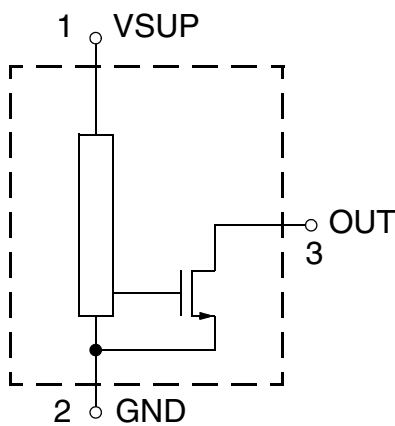


Fig. 4–5: Pin configuration

## 4.4. Dimensions of Sensitive Area

Hall plate area = 0.2 mm × 0.1 mm

See Fig. 4–1 on page 21 for more information on the Hall plate position.

## 4.5. Absolute Maximum Ratings

Stresses beyond those listed in the “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only. Functional operation of the device at these conditions is not implied. Exposure to absolute maximum rating conditions for extended periods will affect device reliability.

This device contains circuitry to protect the inputs and outputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions must be taken to avoid application of any voltage higher than absolute maximum-rated voltages to this circuit.

All voltages listed are referenced to ground (GND).

Symbol	Parameter	Pin No.	Min.	Max.	Unit	Notes
V <sub>SUP</sub>	Supply Voltage	1	-8.5 -14.4 -15	8.5 14.4 16	V	t < 96 h <sup>2)</sup> t < 10 min <sup>2)3)</sup> t < 1 min <sup>2)3)</sup>
V <sub>OUT</sub>	Output Voltage	3	-0.5 <sup>1)</sup> -0.5 <sup>1)</sup> -0.5 <sup>1)</sup>	8.5 14.4 16	V	t < 96 h <sup>2)</sup> t < 10 min <sup>2)</sup> t < 1 min <sup>2)</sup>
V <sub>OUT</sub> -V <sub>SUP</sub>	Excess of Output Voltage over Supply Voltage	1, 3	-	0.5	V	
I <sub>OUT</sub>	Continuous Output Current	3	-5	5	mA	
t <sub>sh</sub>	Output Short Circuit Duration	3	-	10	min	
T <sub>J</sub>	Junction Temperature under Bias		-40	190	°C	4)
T <sub>STORAGE</sub>	Transportation/Short-Term Storage Temperature		-55	150	°C	Device only without packing material
V <sub>ESD</sub>	ESD Protection at V <sub>SUP</sub> <sup>5)</sup>	1	-4.0	4.0	kV	
	ESD Protection at OUT <sup>5)</sup>	3	-8.0	8.0	kV	
1) Internal protection resistor = 50 Ω 2) No cumulated stress 3) As long as T <sub>Jmax</sub> is not exceeded 4) For 96 h - Please contact TDK-Micronas for other temperature requirements 5) AEC-Q100-002 (100 pF and 1.5 kΩ)						

## 4.6. Storage and Shelf Life

Information related to storage conditions of Micronas sensors is included in the document “Guidelines for the Assembly of Micronas Packages”. It gives recommendations linked to moisture sensitivity level and long-term storage.

It is available on the TDK-Micronas website (<https://www.micronas.com/en/service-center/downloads>) or on the service portal (<https://service.micronas.com>).

## 4.7. Recommended Operating Conditions

Functional operation of the device beyond those indicated in the “Recommended Operating Conditions/Characteristics” is not implied and may result in unpredictable behavior of the device and may reduce reliability and lifetime.

All voltages listed are referenced to ground (GND).

Symbol	Parameter	Pin No.	Min.	Typ.	Max.	Unit	Notes
V <sub>SUP</sub>	Supply Voltage	1	4.5 5.7	5 6	5.5 8.0	V	Normal operation During programming
I <sub>OUT</sub>	Continuous Output Current	3	0	–	5	mA	
R <sub>L</sub>	Load Resistor	3	1.0	10	–	kΩ	
C <sub>L</sub>	Load Capacitance	3	0.33	–	47	nF	
N <sub>PRG</sub>	Number of EEPROM Programming Cycles	–	–	–	100	–	0 °C < T <sub>amb</sub> < 55 °C
T <sub>J</sub>	Junction Operating Temperature <sup>1)</sup>	–	–40 –40 –40	– – –	125 150 170	°C	for 8000 h <sup>2)</sup> for 2000 h <sup>2)</sup> for 1000 h <sup>2)</sup>

<sup>1)</sup> Depends on the temperature profile of the application. Please contact TDK-Micronas for life time calculations.

<sup>2)</sup> Time values are not cumulative.

## 4.8. Characteristics

at  $T_J = -40\text{ °C}$  to  $170\text{ °C}$ ,  $V_{SUP} = 4.5\text{ V}$  to  $5.5\text{ V}$ ,  $GND = 0\text{ V}$ , after programming the sensor and locking the EEPROM, at Recommended Operation Conditions if not otherwise specified in the column “Notes”. Typical characteristics for  $T_J = 25\text{ °C}$  and  $V_{SUP} = 5\text{ V}$ .

Symbol	Parameter	Pin No.	Min.	Typ.	Max.	Unit	Conditions
$I_{SUP}$	Supply Current over Temperature Range	1	5	6.75	8.5	mA	
$t_{startup}$	Power-Up Time (Time to reach stabilized Output duty cycle) <sup>1)</sup>	3	$2/f_{PWM}$	–	$8/f_{PWM}$	ms	Time where MDATA is available and first PWM period starts with reliable value (99% of final duty cycle)
<b>Signal</b>							
–	Resolution	3	–	10	–	Bit	
$f_s$	Sampling Frequency	–	–	8	–	kSps	DSDOUBLE = 0
		–	–	16	–	kSps	DSDOUBLE = 1
INL	Non-Linearity of Output Voltage over Temperature <sup>2)</sup>	3	–1.0	0	1.0	%	of Supply Voltage (Linear regression) $T_J = 25\text{ °C}$
BW	Small Signal Bandwidth (–3 dB) <sup>2)</sup>	3	2.25	2.5	–	kHz	$B_{AC} < 10\text{ mT}$ , $f_s = 8\text{ kHz}$
			4.5	5	–		
<sup>1)</sup> Guaranteed by design <sup>2)</sup> Characterized on small sample size, not tested							

Symbol	Parameter	Pin No.	Min.	Typ.	Max.	Unit	Conditions		
CLAMP <sub>L</sub>	Clamp Low <sup>1)</sup>	3	–	0	–	%DC	CLAMP_SP	CLEVEL	
			–	5	–			0	00
			–	10	–			0	01
			–	15	–			0	10
			–	5	–			0	10
			–	10	–			1	00
			–	20	–			1	01
			–	10	–			1	10
CLAMP <sub>H</sub>	Clamp High <sup>1)</sup>	3	–	100	–	%DC	CLAMP_SP	CLEVEL	
			–	95	–			0	00
			–	90	–			0	01
			–	85	–			0	10
			–	90	–			0	10
			–	95	–			1	00
			–	90	–			1	01
			–	80	–			1	10
DUTY <sub>Offset</sub>	Output offset Duty cycle	3	49	50	51	%	B = 0 mT, T <sub>J</sub> = 25 °C,		
<b>PWM</b>									
f <sub>PWM</sub>	PWM frequency	3	0.9 x f <sub>PWM</sub>	2 1 0.5 0.25	1.1 x f <sub>PWM</sub>	kHz	Customer programmable		
J <sub>PWM</sub>	PWM frequency Jitter <sup>1)</sup>	3		0.02	0.04	%	2 consecutive periods		
<b>Output Pin</b>									
V <sub>OUTL</sub>	Output Low Voltage	3	–	0.2	0.3	V	V <sub>SUP</sub> = 5 V, I <sub>OUT</sub> = –5 mA		
V <sub>OUTH</sub>	Output High Voltage	3	4.85	4.95	–	V			
t <sub>rise</sub>	Rise time V <sub>OUT</sub> 10% to 90% <sup>1)</sup>	3	0.7	1	1.4	μs	R <sub>pull-up</sub> = 1 kΩ ±10%, C <sub>load</sub> = 470 pF ±20%		
t <sub>fall</sub>	Fall time V <sub>OUT</sub> 90% to 10% <sup>1)</sup>	3	20	40	80	ns			
R <sub>OUT</sub>	Output Resistance over Recommended Operating Range	3	–	45	–	Ω	V <sub>OUT</sub> ≤ V <sub>OUTLmax</sub>		

Symbol	Parameter	Pin No.	Min.	Typ.	Max.	Unit	Conditions
$t_{resp(PWM)}$	Response Time of PWM Output <sup>1)</sup>	3	-	1.5	1.66	ms	time from 50% magnetic step like signal $B_{step}$ to 50% of final output duty cycle
$t_{set(PWM)}$	Settling Time of PWM Output	3	-	1.0	1.2	ms	time from 10% to 90% of final output duty cycle as response of step like magnetic signal $B_{step}$ from 0 mT to $B_{max}$
<b>TO92UA Package</b>							
$R_{thja}$	Thermal Resistance Junction to Air	-	-	-	250	K/W	Determined with a 1s0p board
$R_{thjc}$	Thermal Resistance Junction to Case	-	-	-	70	K/W	
<sup>1)</sup> Guaranteed by design <sup>2)</sup> Characterized on small sample size, not tested							

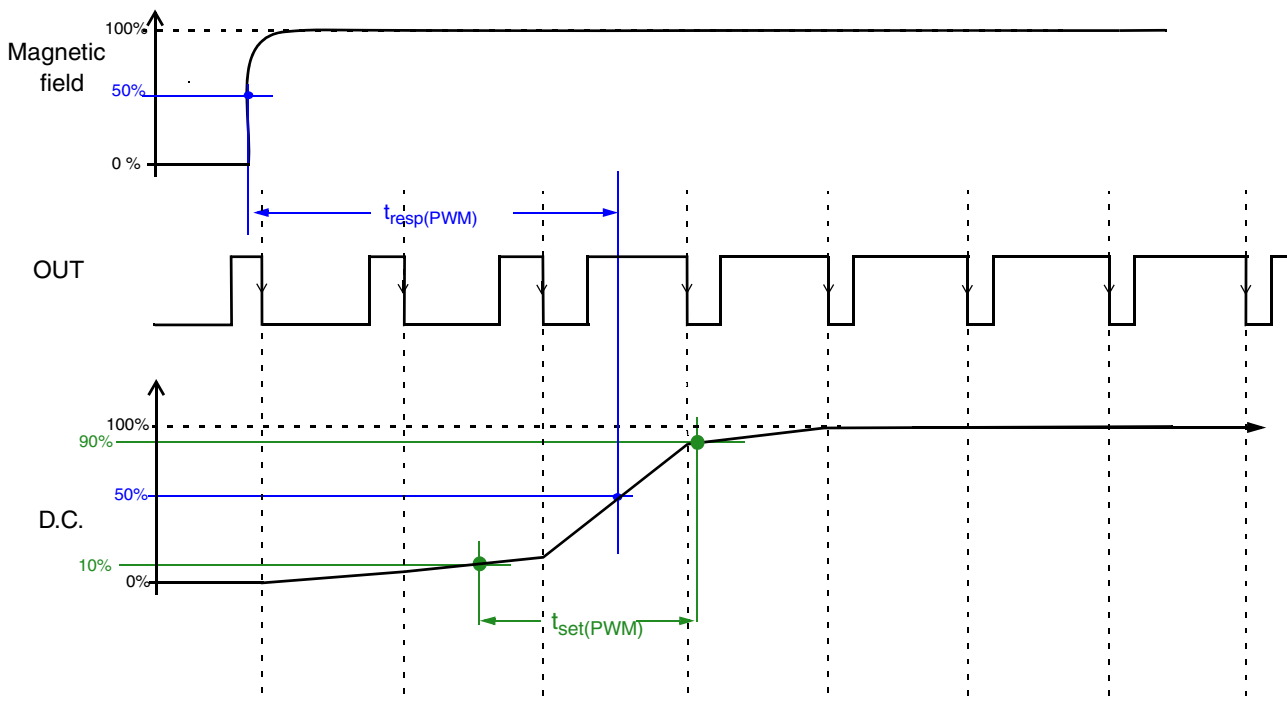


Fig. 4-6: Response time and settling time of PWM output signal

#### 4.9. Power-On Reset / Undervoltage Detection

at  $T_J = -40\text{ °C}$  to  $170\text{ °C}$ ,  $GND=0\text{ V}$ , typical characteristics for  $T_J = 25\text{ °C}$ , after programming and locking.

Symbol	Parameter	Pin	Min.	Typ.	Max.	Unit	Test Conditions
$V_{POR\_LH}$	Undervoltage Detection Level (Power-On Reset, Rising Supply) <sup>1)</sup>	1	4.15	4.3	4.45	V	
$V_{POR\_HL}$	Undervoltage Detection Level (Power-On Reset, Falling Supply) <sup>1)</sup>	1	3.9	4.05	4.25	V	
$V_{POR\_HYS}$	Undervoltage/POR Detection Level Hysteresis <sup>1)</sup>	1	150	225	300	mV	
1) Characterized on small sample size, not tested							

## 4.10. Magnetic Characteristics

at Recommended Operating Conditions if not otherwise specified in the column 'Notes',  $T_J = -40\text{ °C}$  to  $170\text{ °C}$ ,  $V_{SUP} = 4.5\text{ V}$  to  $5.5\text{ V}$ , after programming the sensor and locking the EEPROM. Typical Characteristics for  $T_A = 25\text{ °C}$  and  $V_{SUP} = 5\text{ V}$ .

Symbol	Parameter	Pin No.	Values			Unit	Notes
			Min.	Typ.	Max.		
RANGE <sub>ABS</sub>	Absolute Magnetic Range of A/D Converter over temperature	–	80	100	120	%	% of nominal RANGE Nominal RANGE programmable from 20 mT up to 160 mT
RANGE	Magnetic-field range	–	±20	±80	±160	mT	TO92UA-1/-2
SENS	Sensitivity	3	±0.2		±2.2	%DC /mT	Depending on magnetic-field range <sup>1)</sup> and SENSIVITY register content
ΔSens <sub>trim</sub>	Trim Step for Absolute Sensitivity	3	0.006		0.02	%DC /mT	At min. sensitivity At max. sensitivity
ΔOffset <sub>trim</sub>	Offset Trim	3	±0.05 ±0.2		±6.25 ±25	%DC	OALN = 0 OALN = 1
ES	Sensitivity Error over Temperature Range <sup>1)</sup>	3	–6	0	6	%	Part to part variation for certain combinations of TC and TCSQ (see Section 4.10.1.)
B <sub>OFFSET</sub>	Magnetic Offset	3	–2	0	2	mT	B = 0 mT, T <sub>A</sub> = 25 °C
ΔB <sub>OFFSET</sub>	Magnetic Offset Drift over temperature range <sup>1)</sup> $B_{OFFSET}(T) - B_{OFFSET}(25\text{ °C})$	3	–600	0	600	μT	B = 0 mT, RANGE = ±40 mT, Sens = 100 mV/mT
B <sub>Hysteresis</sub>	Magnetic Hysteresis <sup>1)</sup>	3	–20	0	20	μT	Range = ±40 mT
<sup>1)</sup> Characterized on small sample size, not tested							



### 4.10.1. Definition of Sensitivity Error ES

ES is the maximum of the absolute value of the quotient of the normalized measured value<sup>1)</sup> over the normalized ideal linear value<sup>2)</sup> minus 1:

$$ES = \max \left( \text{abs} \left( \frac{\text{meas}}{\text{ideal}} - 1 \right) \right) \Big|_{[T_{\min}, T_{\max}]}$$

In the example shown in Fig. 4–7 the maximum error occurs at –10 °C:

$$ES = \frac{1.001}{0.993} - 1 = 0.8\%$$

- 1) normalized to achieve a least-square-fit straight-line that has a value of 1 at 25 °C
- 2) normalized to achieve a value of 1 at 25 °C

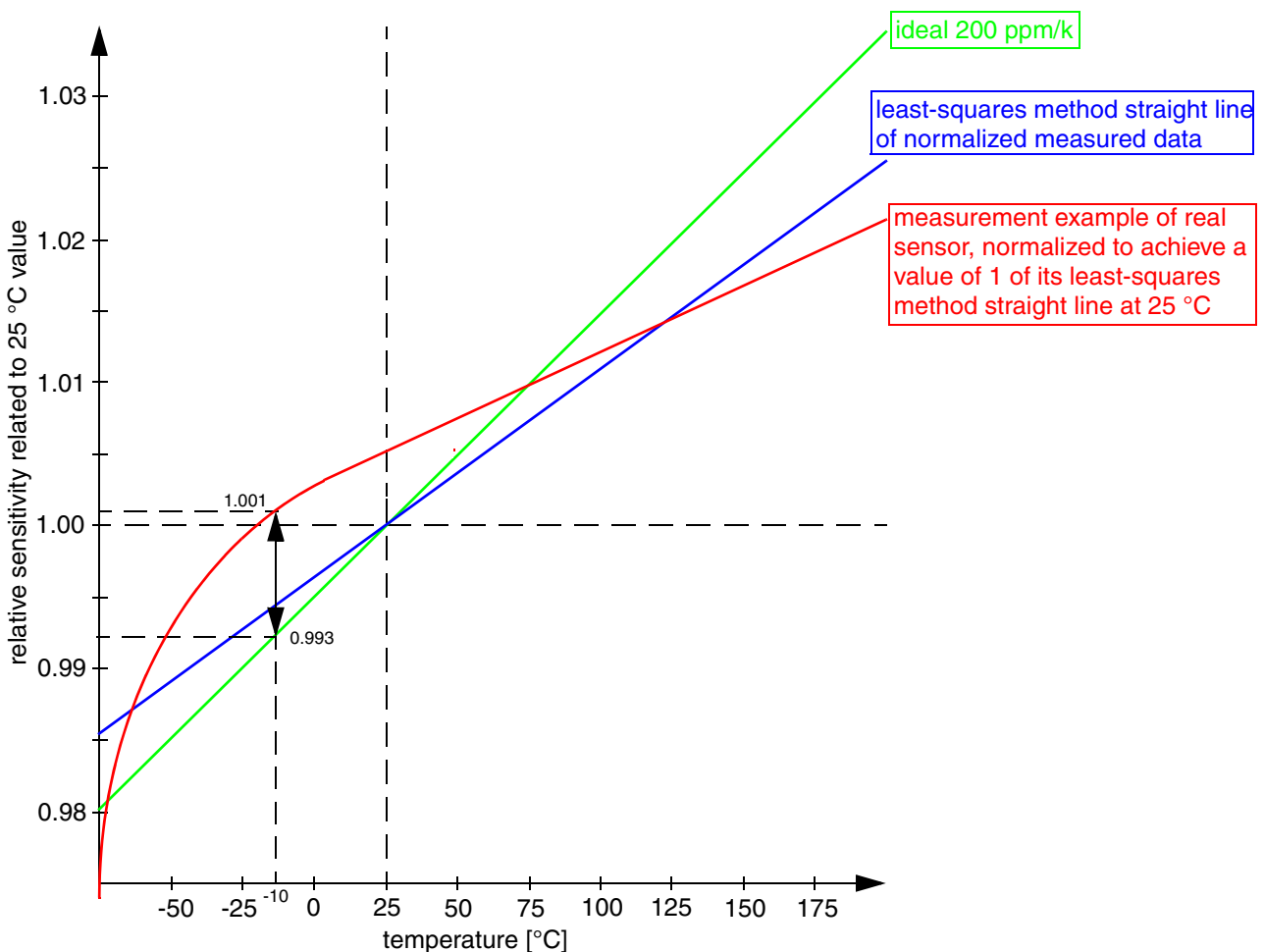


Fig. 4–7: Definition of Sensitivity Error ES

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## 5. Application Notes

### 5.1. Ambient Temperature

Due to the internal power dissipation, the temperature on the silicon chip (junction temperature  $T_J$ ) is higher than the temperature outside the package (ambient temperature  $T_A$ ).

$$T_J = T_A + \Delta T$$

At static conditions and continuous operation, the following equation applies:

$$\Delta T = I_{SUP} * V_{SUP} * R_{thjX}$$

The X represents junction to air or to case.

In order to estimate the temperature difference  $\Delta T$  between the junction and the respective reference (e.g. air, case, or solder point) use the max. parameters for  $I_{SUP}$ ,  $R_{thX}$ , and the max. value for  $V_{SUP}$  from the application.

The following example shows the result for junction to air conditions.  $V_{SUP} = 5.5 V$ ,  $R_{thja} = 250 K/W$  and  $I_{SUP} = 10 mA$  the temperature difference  $\Delta T = 13.75 K$ .

The junction temperature  $T_J$  is specified. The maximum ambient temperature  $T_{Amax}$  can be estimated as:

$$T_{Amax} = T_{Jmax} - \Delta T$$

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**Note** The calculated self-heating of the devices is only valid for the Rth test boards. Depending on the application setup the final results in an application environment might deviate from these values.

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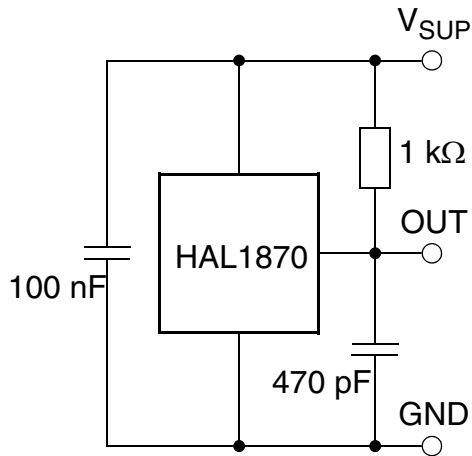
### 5.2. EMC

HAL 1870 is designed for a stabilized 5 V supply. Interferences and disturbances conducted along the 12 V onboard system (product standard ISO 7637 part 1) are not relevant for these applications.

For applications with disturbances by capacitive or inductive coupling on the supply line or radiated disturbances, the application circuit shown in Fig. 5–1 on page 35 is recommended. Applications with this arrangement should pass the EMC tests according to the product standards ISO 7637 part 3 (electrical transient transmission by capacitive or inductive coupling).

### 5.3. Application Circuit

For EMC protection, it is recommended to connect a 470 pF capacitor between ground and output voltage pin as well as a 100 nF capacitor between supply and ground as shown in Fig. 5–1.



**Fig. 5–1:** Recommended application circuit

## 5.4. Temperature Compensation

The relationship between the temperature coefficient of the magnet and the corresponding TC and TCSQ codes for linear compensation is given in the following table. In addition to the linear change of the magnetic field with temperature, the curvature can be adjusted as well. For this purpose, other TC and TCSQ combinations are required which are not shown in the table. Please contact TDK-Micronas for more detailed information on this higher order temperature compensation.

Temperature Coefficient of Magnet System (ppm/K)	TC	TCSQ
2100	5	-9
1800	7	-8
1500	10	-8
1200	13	-6
900	16	-5
500	20	-5
150	23	-4
0	25	-4
-300	28	-3
-500	29	-3
-750	32	-2
-1000	34	-2
-1500	39	-2
-2100	45	0
-2700	51	1

**Note** For development or evaluation purposes TDK-Micronas recommends to use the HAL 1870/1880/1890 Programming Environment to find optimal settings for temperature coefficients. Please contact TDK-Micronas for more detailed information.

## 6. Programming of the Sensor

HAL 1870 features two different operating modes. In **Application Mode** the sensor provides a PWM signal/output. In **Programming Mode** it is possible to change the register settings of the sensor.

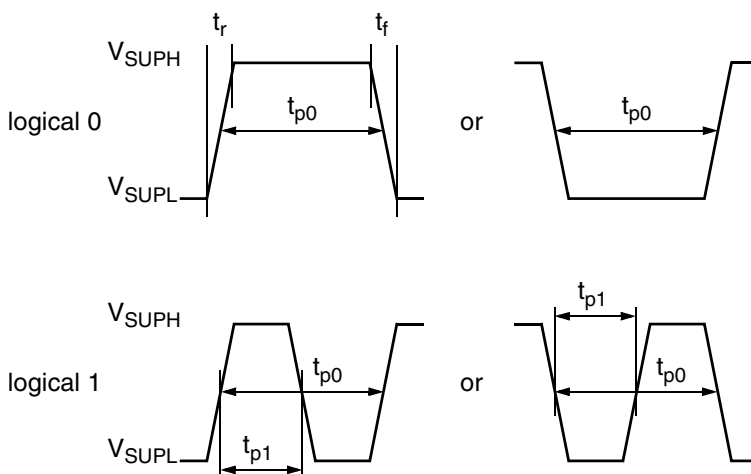
After power-up the sensor is always operating in the **Application Mode**. As long as the sensor is not locked it can be switched to the **Programming Mode** by voltage pulse on the sensor OUT pin.

### 6.1. Programming Interface

In **Programming Mode** the sensor is addressed by modulating a serial telegram on the sensor's output pin or on the sensor's supply voltage. The sensor answers with a modulation of the output voltage.

A logical "0" is coded as no level change within the bit time. A logical "1" is coded as a level change of typically 50% of the bit time. After each bit, a level change occurs (see Fig. 6–1).

The serial telegram is used to transmit the EEPROM content, error codes and digital values of the magnetic field from and to the sensor.



**Fig. 6–1:** Definition of logical 0 and 1 bit

A description of the communication protocol and the programming of the sensor is available in a separate document (Application Note "HAL 1870/1880/1890 Programming Guide").

**Table 6–1:** Telegram parameters for host (All voltages are referenced to GND.)

Symbol	Parameter	Pin No.	Limit Values			Unit
			Min.	Typ.	Max.	
$V_{SUPL}$	Supply Voltage for Low level during programming through sensor VSUP pin	1	5	–	6	V
$V_{SUPH}$	Supply Voltage for High level during programming through sensor VSUP pin	1	8	–	9	V
$V_{SUPProgram}$	Supply Voltage for EEPROM programming	1	5.7	6	6.5	V
$t_{p0}$	Bit time if command send to the sensor	1, 3	–	1024	–	$\mu$ s
$t_{p1}$	BiPhase half bit time	1, 3	–	0.5	–	$t_{p0}$
$t_{pOUT}$	Bit time for sensor answer	3	–	1024	–	$\mu$ s

## 6.2. Programming Environment and Tools

For the programming of HAL 1870 during product development a programming tool including hardware and software is available on request. It is recommended to use the TDK MSP V1.x Magnetic Sensor Programmer or TDK-Micronas' tool kit (HAL USB-Kit and LabView™ programming environment) in order to ease the product development. The details of programming sequences can be found in the “HAL 1870/1880/1890 User Manual” and in the “HAL 1870/1880/1890 Programming Guide”.

## 6.3. Programming Information

For production and qualification tests, it is mandatory to set the LOCK bit after final adjustment and programming of HAL 1870. The lock function is active after the next power-up of the sensor.

The success of the lock process shall be checked by reading the status of the LOCK bit after locking and by a negative communication test after power-on reset.

HAL 1870 features a diagnostic register to check the success and quality of the programming process. Detailed information about programming the sensor can be found in the “HAL 1870/1880/1890 User Manual” and in the “HAL 1870/1880/1890 Programming Guide”.

EMI (Electromagnetic Interference) may disturb the programming pulses. Please take precautions against EMI.

## 7. Document History

1. Data Sheet: "HAL 1870 Programmable Linear Hall-Effect Sensor with PWM Output", Oct. 23, 2020, DSH000208\_001EN. First release of the data sheet.